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# Understanding <u>Embedded - FPGAs (Field Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

## **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Discontinued at Digi-Key
Number of LABs/CLBs	160
Number of Logic Elements/Cells	1280
Total RAM Bits	65536
Number of I/O	28
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	36-UFBGA, WLCSP
Supplier Device Package	36-WLCSP (2.54x2.59)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/lcmxo3lf-1300e-5uwg36itr50

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



# MachXO3 Family Data Sheet Introduction

January 2016 Advance Data Sheet DS1047

## **Features**

#### ■ Solutions

- Smallest footprint, lowest power, high data throughput bridging solutions for mobile applications
- Optimized footprint, logic density, IO count, IO performance devices for IO management and logic applications
- High IO/logic, lowest cost/IO, high IO devices for IO expansion applications

#### ■ Flexible Architecture

- Logic Density ranging from 640 to 9.4K LUT4
- High IO to LUT ratio with up to 384 IO pins

## ■ Advanced Packaging

- 0.4 mm pitch: 1K to 4K densities in very small footprint WLCSP (2.5 mm x 2.5 mm to 3.8 mm x 3.8 mm) with 28 to 63 IOs
- 0.5 mm pitch: 640 to 6.9K LUT densities in 6 mm x 6 mm to 10 mm x 10 mm BGA packages with up to 281 IOs
- 0.8 mm pitch: 1K to 9.4K densities with up to 384 IOs in BGA packages

## ■ Pre-Engineered Source Synchronous I/O

- DDR registers in I/O cells
- · Dedicated gearing logic
- 7:1 Gearing for Display I/Os
- · Generic DDR, DDRx2, DDRx4

## ■ High Performance, Flexible I/O Buffer

- Programmable syslO<sup>™</sup> buffer supports wide range of interfaces:
  - LVCMOS 3.3/2.5/1.8/1.5/1.2
  - LVTTL
  - LVDS, Bus-LVDS, MLVDS, LVPECL
  - MIPI D-PHY Emulated
  - Schmitt trigger inputs, up to 0.5 V hysteresis
- Ideal for IO bridging applications
- I/Os support hot socketing
- On-chip differential termination
- Programmable pull-up or pull-down mode

## Flexible On-Chip Clocking

- · Eight primary clocks
- Up to two edge clocks for high-speed I/O interfaces (top and bottom sides only)
- Up to two analog PLLs per device with fractional-n frequency synthesis
  - Wide input frequency range (7 MHz to 400 MHz)

## Non-volatile, Multi-time Programmable

- Instant-on
  - Powers up in microseconds
- Optional dual boot with external SPI memory
- Single-chip, secure solution
- Programmable through JTAG, SPI or I<sup>2</sup>C
- MachXO3L includes multi-time programmable NVCM
- MachXO3LF infinitely reconfigurable Flash
  - Supports background programming of nonvolatile memory

#### TransFR Reconfiguration

In-field logic update while IO holds the system state

#### ■ Enhanced System Level Support

- On-chip hardened functions: SPI, I<sup>2</sup>C, timer/ counter
- On-chip oscillator with 5.5% accuracy
- Unique TraceID for system tracking
- Single power supply with extended operating range
- IEEE Standard 1149.1 boundary scan
- IEEE 1532 compliant in-system programming

## Applications

- Consumer Electronics
- · Compute and Storage
- Wireless Communications
- Industrial Control Systems
- · Automotive System

## ■ Low Cost Migration Path

- Migration from the Flash based MachXO3LF to the NVCM based MachXO3L
- Pin compatible and equivalent timing



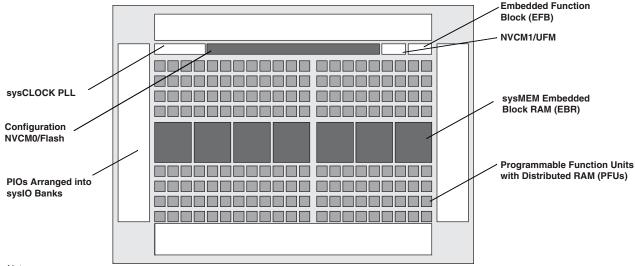
# MachXO3 Family Data Sheet Architecture

February 2017 Advance Data Sheet DS1047

## **Architecture Overview**

The MachXO3L/LF family architecture contains an array of logic blocks surrounded by Programmable I/O (PIO). All logic density devices in this family have sysCLOCK<sup>™</sup> PLLs and blocks of sysMEM Embedded Block RAM (EBRs). Figure 2-1 and Figure 2-2 show the block diagrams of the various family members.

Figure 2-1. Top View of the MachXO3L/LF-1300 Device



#### Notes:

- MachXO3L/LF-640 is similar to MachXO3L/LF-1300. MachXO3L/LF-640 has a lower LUT count.
- MachXO3L devices have NVCM, MachXO3LF devices have Flash.

www.latticesemi.com 2-1 DS1047 Introduction 0.8



## Table 2-4. PLL Signal Descriptions (Continued)

Port Name	I/O	Description	
CLKOP	0	Primary PLL output clock (with phase shift adjustment)	
CLKOS	0	Secondary PLL output clock (with phase shift adjust)	
CLKOS2	0	Secondary PLL output clock2 (with phase shift adjust)	
CLKOS3	0	Secondary PLL output clock3 (with phase shift adjust)	
LOCK	0	PLL LOCK, asynchronous signal. Active high indicates PLL is locked to input and feedback signals.	
DPHSRC	0	Dynamic Phase source – ports or WISHBONE is active	
STDBY	I	Standby signal to power down the PLL	
RST	I	PLL reset without resetting the M-divider. Active high reset.	
RESETM	I	PLL reset - includes resetting the M-divider. Active high reset.	
RESETC	I	Reset for CLKOS2 output divider only. Active high reset.	
RESETD	I	Reset for CLKOS3 output divider only. Active high reset.	
ENCLKOP	I	Enable PLL output CLKOP	
ENCLKOS	I	Enable PLL output CLKOS when port is active	
ENCLKOS2	I	Enable PLL output CLKOS2 when port is active	
ENCLKOS3	I	Enable PLL output CLKOS3 when port is active	
PLLCLK	I	PLL data bus clock input signal	
PLLRST	1	PLL data bus reset. This resets only the data bus not any register values.	
PLLSTB	I	PLL data bus strobe signal	
PLLWE	I	PLL data bus write enable signal	
PLLADDR [4:0]	1	PLL data bus address	
PLLDATI [7:0]	1	PLL data bus data input	
PLLDATO [7:0]	0	PLL data bus data output	
PLLACK	0	PLL data bus acknowledge signal	

## sysMEM Embedded Block RAM Memory

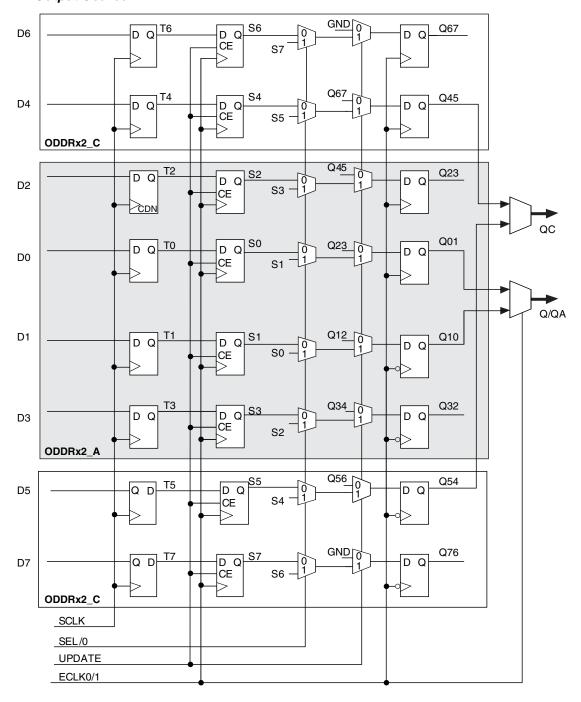
The MachXO3L/LF devices contain sysMEM Embedded Block RAMs (EBRs). The EBR consists of a 9-Kbit RAM, with dedicated input and output registers. This memory can be used for a wide variety of purposes including data buffering, PROM for the soft processor and FIFO.

## sysMEM Memory Block

The sysMEM block can implement single port, dual port, pseudo dual port, or FIFO memories. Each block can be used in a variety of depths and widths as shown in Table 2-5.



Figure 2-14. Output Gearbox



More information on the output gearbox is available in TN1281, Implementing High-Speed Interfaces with MachXO3 Devices.



Figure 2-18. PC Core Block Diagram

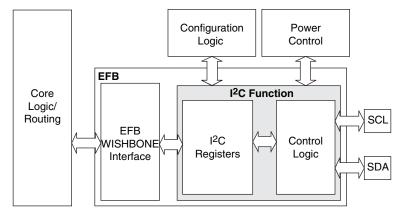


Table 2-14 describes the signals interfacing with the I<sup>2</sup>C cores.

Table 2-14. PC Core Signal Description

Signal Name	I/O	Description
i2c_scl	Bi-directional	Bi-directional clock line of the I <sup>2</sup> C core. The signal is an output if the I <sup>2</sup> C core is in master mode. The signal is an input if the I <sup>2</sup> C core is in slave mode. MUST be routed directly to the pre-assigned I/O of the chip. Refer to the Pinout Information section of this document for detailed pad and pin locations of I <sup>2</sup> C ports in each MachXO3L/LF device.
i2c_sda	Bi-directional	Bi-directional data line of the I <sup>2</sup> C core. The signal is an output when data is transmitted from the I <sup>2</sup> C core. The signal is an input when data is received into the I <sup>2</sup> C core. MUST be routed directly to the pre-assigned I/O of the chip. Refer to the Pinout Information section of this document for detailed pad and pin locations of I <sup>2</sup> C ports in each MachXO3L/LF device.
i2c_irqo	Output	Interrupt request output signal of the I <sup>2</sup> C core. The intended usage of this signal is for it to be connected to the WISHBONE master controller (i.e. a microcontroller or state machine) and request an interrupt when a specific condition is met. These conditions are described with the I <sup>2</sup> C register definitions.
cfg_wake	Output	Wake-up signal – To be connected only to the power module of the MachXO3L/LF device. The signal is enabled only if the "Wakeup Enable" feature has been set within the EFB GUI, I <sup>2</sup> C Tab.
cfg_stdby	Output	Stand-by signal – To be connected only to the power module of the MachXO3L/LF device. The signal is enabled only if the "Wakeup Enable" feature has been set within the EFB GUI, I <sup>2</sup> C Tab.

#### **Hardened SPI IP Core**

Every MachXO3L/LF device has a hard SPI IP core that can be configured as a SPI master or slave. When the IP core is configured as a master it will be able to control other SPI enabled chips connected to the SPI bus. When the core is configured as the slave, the device will be able to interface to an external SPI master. The SPI IP core on MachXO3L/LF devices supports the following functions:

- · Configurable Master and Slave modes
- Full-Duplex data transfer
- Mode fault error flag with CPU interrupt capability
- · Double-buffered data register
- · Serial clock with programmable polarity and phase
- · LSB First or MSB First Data Transfer
- Interface to custom logic through 8-bit WISHBONE interface



There are some limitations on the use of the hardened user SPI. These are defined in the following technical notes:

- TN1087, Minimizing System Interruption During Configuration Using TransFR Technology (Appendix B)
- TN1293, Using Hardened Control Functions in MachXO3 Devices

Figure 2-19. SPI Core Block Diagram

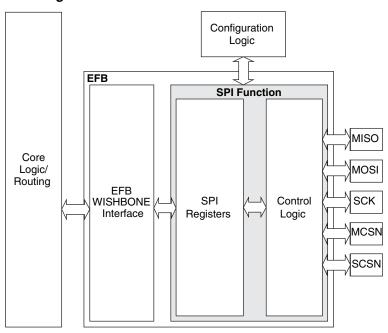


Table 2-15 describes the signals interfacing with the SPI cores.

Table 2-15. SPI Core Signal Description

Signal Name	I/O	Master/Slave	Description
spi_csn[0]	0	Master	SPI master chip-select output
spi_csn[17]	0	Master	Additional SPI chip-select outputs (total up to eight slaves)
spi_scsn	I	Slave	SPI slave chip-select input
spi_irq	0	Master/Slave	Interrupt request
spi_clk	I/O	Master/Slave	SPI clock. Output in master mode. Input in slave mode.
spi_miso	I/O	Master/Slave	SPI data. Input in master mode. Output in slave mode.
spi_mosi	I/O	Master/Slave	SPI data. Output in master mode. Input in slave mode.
sn	I	Slave	Configuration Slave Chip Select (active low), dedicated for selecting the Configuration Logic.
cfg_stdby	0	Master/Slave	Stand-by signal – To be connected only to the power module of the MachXO3L/LF device. The signal is enabled only if the "Wakeup Enable" feature has been set within the EFB GUI, SPI Tab.
cfg_wake	0	Master/Slave	Wake-up signal – To be connected only to the power module of the MachXO3L/LF device. The signal is enabled only if the "Wakeup Enable" feature has been set within the EFB GUI, SPI Tab.



#### **Hardened Timer/Counter**

MachXO3L/LF devices provide a hard Timer/Counter IP core. This Timer/Counter is a general purpose, bi-directional, 16-bit timer/counter module with independent output compare units and PWM support. The Timer/Counter supports the following functions:

- Supports the following modes of operation:
  - Watchdog timer
  - Clear timer on compare match
  - Fast PWM
  - Phase and Frequency Correct PWM
- · Programmable clock input source
- Programmable input clock prescaler
- · One static interrupt output to routing
- One wake-up interrupt to on-chip standby mode controller.
- · Three independent interrupt sources: overflow, output compare match, and input capture
- · Auto reload
- · Time-stamping support on the input capture unit
- · Waveform generation on the output
- · Glitch-free PWM waveform generation with variable PWM period
- · Internal WISHBONE bus access to the control and status registers
- Stand-alone mode with preloaded control registers and direct reset input

Figure 2-20. Timer/Counter Block Diagram

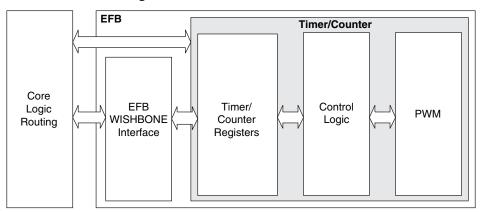


Table 2-16. Timer/Counter Signal Description

Port	I/O	Description
tc_clki	I	Timer/Counter input clock signal
tc_rstn	I	Register tc_rstn_ena is preloaded by configuration to always keep this pin enabled
tc_ic	I	Input capture trigger event, applicable for non-pwm modes with WISHBONE interface. If enabled, a rising edge of this signal will be detected and synchronized to capture tc_cnt value into tc_icr for time-stamping.
tc_int	0	Without WISHBONE – Can be used as overflow flag With WISHBONE – Controlled by three IRQ registers
tc_oc	0	Timer counter output signal



For more details on these embedded functions, please refer to TN1293, Using Hardened Control Functions in MachXO3 Devices.

## **User Flash Memory (UFM)**

MachXO3LF devices provide a User Flash Memory block, which can be used for a variety of applications including storing a portion of the configuration image, initializing EBRs, to store PROM data or, as a general purpose user Flash memory. The UFM block connects to the device core through the embedded function block WISHBONE interface. Users can also access the UFM block through the JTAG, I2C and SPI interfaces of the device. The UFM block offers the following features:

- Non-volatile storage up to 256 kbits
- 100K write cycles
- Write access is performed page-wise; each page has 128 bits (16 bytes)
- · Auto-increment addressing
- WISHBONE interface

For more information on the UFM, please refer to TN1293, Using Hardened Control Functions in MachXO3 Devices.

## **Standby Mode and Power Saving Options**

MachXO3L/LF devices are available in two options, the C and E devices. The C devices have a built-in voltage regulator to allow for 2.5 V  $V_{CC}$  and 3.3 V  $V_{CC}$  while the E devices operate at 1.2 V  $V_{CC}$ .

MachXO3L/LF devices have been designed with features that allow users to meet the static and dynamic power requirements of their applications by controlling various device subsystems such as the bandgap, power-on-reset circuitry, I/O bank controllers, power guard, on-chip oscillator, PLLs, etc. In order to maximize power savings, MachXO3L/LF devices support a low power Stand-by mode.

In the stand-by mode the MachXO3L/LF devices are powered on and configured. Internal logic, I/Os and memories are switched on and remain operational, as the user logic waits for an external input. The device enters this mode when the standby input of the standby controller is toggled or when an appropriate I<sup>2</sup>C or JTAG instruction is issued by an external master. Various subsystems in the device such as the band gap, power-on-reset circuitry etc can be configured such that they are automatically turned "off" or go into a low power consumption state to save power when the device enters this state. Note that the MachXO3L/LF devices are powered on when in standby mode and all power supplies should remain in the Recommended Operating Conditions.



## **TraceID**

Each MachXO3L/LF device contains a unique (per device), TraceID that can be used for tracking purposes or for IP security applications. The TraceID is 64 bits long. Eight out of 64 bits are user-programmable, the remaining 56 bits are factory-programmed. The TraceID is accessible through the EFB WISHBONE interface and can also be accessed through the SPI, I<sup>2</sup>C, or JTAG interfaces.

## **Density Shifting**

The MachXO3L/LF family has been designed to enable density migration within the same package. Furthermore, the architecture ensures a high success rate when performing design migration from lower density devices to higher density devices. In many cases, it is also possible to shift a lower utilization design targeted for a high-density device to a lower density device. However, the exact details of the final resource utilization will impact the likely success in each case. When migrating from lower to higher density or higher to lower density, ensure to review all the power supplies and NC pins of the chosen devices. For more details refer to the MachXO3 migration files.



# Power-On-Reset Voltage Levels<sup>1, 2, 3, 4, 5</sup>

Symbol	Parameter	Min.	Тур.	Max.	Units
V <sub>PORUP</sub>	Power-On-Reset ramp up trip point (band gap based circuit monitoring $V_{\text{CCINT}}$ and $V_{\text{CCIO0}}$ )	0.9	_	1.06	V
V <sub>PORUPEXT</sub>	Power-On-Reset ramp up trip point (band gap based circuit monitoring external $V_{\rm CC}$ power supply)	1.5	_	2.1	V
V <sub>PORDNBG</sub>	Power-On-Reset ramp down trip point (band gap based circuit monitoring $V_{\text{CCINT}}$ )	0.75	_	0.93	V
V <sub>PORDNBGEXT</sub>	Power-On-Reset ramp down trip point (band gap based circuit monitoring $V_{CC}$ )	0.98	_	1.33	V
V <sub>PORDNSRAM</sub>	Power-On-Reset ramp down trip point (SRAM based circuit monitoring $V_{\text{CCINT}}$ )	_	0.6	_	V
V <sub>PORDNSRAMEXT</sub>	Power-On-Reset ramp down trip point (SRAM based circuit monitoring $V_{CC}$ )	_	0.96	_	V

- 1. These POR trip points are only provided for guidance. Device operation is only characterized for power supply voltages specified under recommended operating conditions.
- 2. For devices without voltage regulators  $V_{CCINT}$  is the same as the  $V_{CC}$  supply voltage. For devices with voltage regulators,  $V_{CCINT}$  is regulated from the  $V_{CC}$  supply voltage.
- 3. Note that V<sub>PORUP</sub> (min.) and V<sub>PORDNBG</sub> (max.) are in different process corners. For any given process corner V<sub>PORDNBG</sub> (max.) is always 12.0 mV below V<sub>PORUP</sub> (min.).
- 4. V<sub>PORUPEXT</sub> is for C devices only. In these devices a separate POR circuit monitors the external V<sub>CC</sub> power supply.
- 5. V<sub>CCIO0</sub> does not have a Power-On-Reset ramp down trip point. V<sub>CCIO0</sub> must remain within the Recommended Operating Conditions to ensure proper operation.

## Hot Socketing Specifications<sup>1, 2, 3</sup>

Symbol	Parameter	Condition	Max.	Units
$I_{DK}$	Input or I/O leakage Current	$0 < V_{IN} < V_{IH} (MAX)$	+/-1000	μΑ

<sup>1.</sup> Insensitive to sequence of V<sub>CC</sub> and V<sub>CCIO</sub>. However, assumes monotonic rise/fall rates for V<sub>CC</sub> and V<sub>CCIO</sub>.

## **ESD Performance**

Please refer to the MachXO2 Product Family Qualification Summary for complete qualification data, including ESD performance.

<sup>2.</sup>  $0 < V_{CC} < V_{CC}$  (MAX),  $0 < V_{CCIO} < V_{CCIO}$  (MAX).

<sup>3.</sup>  $I_{DK}$  is additive to  $I_{PU}$ ,  $I_{PD}$  or  $I_{BH}$ .



# Static Supply Current - C/E Devices<sup>1, 2, 3, 6</sup>

Symbol	Parameter	Device	Typ.⁴	Units
I <sub>CC</sub>	Core Power Supply	LCMXO3L/LF-1300C 256 Ball Package	4.8	mA
		LCMXO3L/LF-2100C	4.8	mA
		LCMXO3L/LF-2100C 324 Ball Package	8.45	mA
		LCMXO3L/LF-4300C	8.45	mA
		LCMXO3L/LF-4300C 400 Ball Package	12.87	mA
		LCMXO3L/LF-6900C <sup>7</sup>	12.87	mA
		LCMXO3L/LF-9400C <sup>7</sup>	17.86	mA
		LCMXO3L/LF-640E	1.00	mA
		LCMXO3L/LF-1300E	1.00	mA
		LCMXO3L/LF-1300E 256 Ball Package	1.39	mA
		LCMXO3L/LF-2100E	1.39	mA
		LCMXO3L/LF-2100E 324 Ball Package	2.55	mA
		LCMXO3L/LF-4300E	2.55	mA
		LCMXO3L/LF-6900E	4.06	mA
		LCMXO3L/LF-9400E	5.66	mA
I <sub>CCIO</sub>	Bank Power Supply <sup>5</sup> VCCIO = 2.5 V	All devices	0	mA

- 1. For further information on supply current, please refer to TN1289, Power Estimation and Management for MachXO3 Devices.
- Assumes blank pattern with the following characteristics: all outputs are tri-stated, all inputs are configured as LVCMOS and held at V<sub>CCIO</sub> or GND, on-chip oscillator is off, on-chip PLL is off.
- 3. Frequency = 0 MHz.
- 4.  $T_J = 25$  °C, power supplies at nominal voltage.
- 5. Does not include pull-up/pull-down.
- 6. To determine the MachXO3L/LF peak start-up current data, use the Power Calculator tool.
- 7. Determination of safe ambient operating conditions requires use of the Diamond Power Calculator tool.



## sysIO Differential Electrical Characteristics

The LVDS differential output buffers are available on the top side of the MachXO3L/LF PLD family.

## **LVDS**

## **Over Recommended Operating Conditions**

Parameter Symbol	Parameter Description	Test Conditions	Min.	Тур.	Max.	Units
V V	Input Voltage	V <sub>CCIO</sub> = 3.3 V	0	_	2.605	V
V <sub>INP</sub> , V <sub>INM</sub>		V <sub>CCIO</sub> = 2.5 V	0	_	2.05	V
$V_{THD}$	Differential Input Threshold		±100	_		mV
V	/ <sub>CM</sub> Input Common Mode Voltage	V <sub>CCIO</sub> = 3.3 V	0.05	_	2.6	V
V CM		V <sub>CCIO</sub> = 2.5 V	0.05	_	2.0	V
I <sub>IN</sub>	Input current	Power on	_		±10	μΑ
V <sub>OH</sub>	Output high voltage for V <sub>OP</sub> or V <sub>OM</sub>	R <sub>T</sub> = 100 Ohm	_	1.375		V
V <sub>OL</sub>	Output low voltage for V <sub>OP</sub> or V <sub>OM</sub>	R <sub>T</sub> = 100 Ohm	0.90	1.025	_	V
V <sub>OD</sub>	Output voltage differential	$(V_{OP} - V_{OM}), R_T = 100 Ohm$	250	350	450	mV
$\Delta V_{OD}$	Change in V <sub>OD</sub> between high and low		_	_	50	mV
V <sub>OS</sub>	Output voltage offset	$(V_{OP} - V_{OM})/2$ , $R_T = 100 \text{ Ohm}$	1.125	1.20	1.395	V
ΔV <sub>OS</sub>	Change in V <sub>OS</sub> between H and L		_	_	50	mV
I <sub>OSD</sub>	Output short circuit current	V <sub>OD</sub> = 0 V driver outputs shorted	_	_	24	mA

## DC and Switching Characteristics MachXO3 Family Data Sheet

	1		<b>-6 -5</b>				
_						<u> </u>	
Parameter	Description	Device	Min.	Max.	Min.	Max.	Units
	RX4 Outputs with Clock and Data Centere X.ECLK.Centered <sup>8, 9</sup>	d at Pin Using PCLK Pin fo	or Clock	Input –			
t <sub>DVB</sub>	Output Data Valid Before CLK Output		0.455	_	0.570	_	ns
t <sub>DVA</sub>	Output Data Valid After CLK Output	MachXO3L/LF devices, top side only	0.455	_	0.570	_	ns
f <sub>DATA</sub>	DDRX4 Serial Output Data Speed		_	800	_	630	Mbps
f <sub>DDRX4</sub>	DDRX4 ECLK Frequency (minimum limited by PLL)		_	400	_	315	MHz
f <sub>SCLK</sub>	SCLK Frequency		_	100	_	79	MHz
7:1 LVDS O	7:1 LVDS Outputs – GDDR71_TX.ECLK.7:1 <sup>8,9</sup>						
t <sub>DIB</sub>	Output Data Invalid Before CLK Output		_	0.160	_	0.180	ns
t <sub>DIA</sub>	Output Data Invalid After CLK Output		_	0.160	_	0.180	ns
f <sub>DATA</sub>	DDR71 Serial Output Data Speed	MachXO3L/LF devices,	_	756	_	630	Mbps
f <sub>DDR71</sub>	DDR71 ECLK Frequency	top side only	_	378	_	315	MHz
f <sub>CLKOUT</sub>	7:1 Output Clock Frequency (SCLK) (minimum limited by PLL)		_	108	_	90	MHz
MIPI D-PHY GDDRX4_TX	Outputs with Clock and Data Centered at F K.ECLK.Centered <sup>10, 11, 12</sup>	in Using PCLK Pin for Clo	ck Input	-			
t <sub>DVB</sub>	Output Data Valid Before CLK Output		0.200	_	0.200	_	UI
t <sub>DVA</sub>	Output Data Valid After CLK Output		0.200	_	0.200	_	UI
f <sub>DATA</sub> <sup>14</sup>	MIPI D-PHY Output Data Speed	All MachXO3L/LF	_	900	_	900	Mbps
f <sub>DDRX4</sub> 14	MIPI D-PHY ECLK Frequency (minimum limited by PLL)	devices, top side only	_	450	_	450	MHz
f <sub>SCLK</sub> <sup>14</sup>	SCLK Frequency		_	112.5	_	112.5	MHz

- 1. Exact performance may vary with device and design implementation. Commercial timing numbers are shown at 85 °C and 1.14 V. Other operating conditions, including industrial, can be extracted from the Diamond software.
- 2. General I/O timing numbers based on LVCMOS 2.5, 8 mA, 0pf load, fast slew rate.
- 3. Generic DDR timing numbers based on LVDS I/O (for input, output, and clock ports).
- 4. 7:1 LVDS (GDDR71) uses the LVDS I/O standard (for input, output, and clock ports).
- 5. For Generic DDRX1 mode  $t_{SU}$  =  $t_{HO}$  =  $(t_{DVE}$   $t_{DVA}$  0.03 ns)/2.
- 6. The t<sub>SU DEL</sub> and t<sub>H DEL</sub> values use the SCLK\_ZERHOLD default step size. Each step is 105 ps (-6), 113 ps (-5), 120 ps (-4).
- 7. This number for general purpose usage. Duty cycle tolerance is +/–10%.
- 8. Duty cycle is +/- 5% for system usage.
- 9. Performance is calculated with 0.225 UI.
- 10. Performance is calculated with 0.20 UI.
- 11. Performance for Industrial devices are only supported with VCC between 1.16 V to 1.24 V.
- 12. Performance for Industrial devices and -5 devices are not modeled in the Diamond design tool.
- 13. The above timing numbers are generated using the Diamond design tool. Exact performance may vary with the device selected.
- 14. Above 800 Mbps is only supported with WLCSP and csfBGA packages
- 15. Between 800 Mbps to 900 Mbps:
  - a. VIDTH exceeds the MIPI D-PHY Input DC Conditions Table 3-4 and can be calculated with the equation tSU or tH = -0.0005\*VIDTH + 0.3284
  - b. Example calculations
    - i. tSU and tHO = 0.28 with VIDTH = 100 mV
    - ii. tSU and tHO = 0.25 with VIDTH = 170 mV
    - iii. tSU and tHO = 0.20 with VIDTH = 270 mV



## sysCLOCK PLL Timing

## **Over Recommended Operating Conditions**

Parameter	Descriptions	Conditions	Min.	Max.	Units
f <sub>IN</sub>	Input Clock Frequency (CLKI, CLKFB)		7	400	MHz
f <sub>OUT</sub>	Output Clock Frequency (CLKOP, CLKOS, CLKOS2)		1.5625	400	MHz
f <sub>OUT2</sub>	Output Frequency (CLKOS3 cascaded from CLKOS2)		0.0122	400	MHz
f <sub>VCO</sub>	PLL VCO Frequency		200	800	MHz
f <sub>PFD</sub>	Phase Detector Input Frequency		7	400	MHz
AC Character	istics	•			
t <sub>DT</sub>	Output Clock Duty Cycle	Without duty trim selected <sup>3</sup>	45	55	%
t <sub>DT_TRIM</sub> <sup>7</sup>	Edge Duty Trim Accuracy		-75	75	%
t <sub>PH</sub> <sup>4</sup>	Output Phase Accuracy		-6	6	%
	Output Clock Ported litter	f <sub>OUT</sub> > 100 MHz	<u> </u>	150	ps p-p
	Output Clock Period Jitter	f <sub>OUT</sub> < 100 MHz	<u> </u>	0.007	UIPP
	Output Clask Cyala ta avala littar	f <sub>OUT</sub> > 100 MHz	<u> </u>	180	ps p-p
	Output Clock Cycle-to-cycle Jitter	f <sub>OUT</sub> < 100 MHz	_	0.009	UIPP
± 1.8	Output Clask Phase litter	f <sub>PFD</sub> > 100 MHz	_	160	ps p-p
t <sub>OPJIT</sub> 1,8	Output Clock Phase Jitter	f <sub>PFD</sub> < 100 MHz	_	0.009 160 0.011 230 0.12 230 0.12	UIPP
	Output Clask Davied Litter (Freetieral NI)	f <sub>OUT</sub> > 100 MHz	<u> </u>		ps p-p
	Output Clock Period Jitter (Fractional-N)	f <sub>OUT</sub> < 100 MHz	<u> </u>	0.12	UIPP
	Output Clock Cycle-to-cycle Jitter	f <sub>OUT</sub> > 100 MHz	<u> </u>	230	ps p-p
	(Fractional-N)	f <sub>OUT</sub> < 100 MHz	<u> </u>	0.12	UIPP
t <sub>SPO</sub>	Static Phase Offset	Divider ratio = integer	-120	120	ps
t <sub>W</sub>	Output Clock Pulse Width	At 90% or 10% <sup>3</sup>	0.9	_	ns
t <sub>LOCK</sub> 2, 5	PLL Lock-in Time		<u> </u>	15	ms
t <sub>UNLOCK</sub>	PLL Unlock Time		<b>—</b>	50	ns
<b>.</b> 6	Input Clock Pariod litter	f <sub>PFD</sub> ≥ 20 MHz	<u> </u>	1,000	ps p-p
t <sub>IPJIT</sub> 6	Input Clock Period Jitter	f <sub>PFD</sub> < 20 MHz	<u> </u>	0.02	UIPP
t <sub>HI</sub>	Input Clock High Time	90% to 90%	0.5	_	ns
t <sub>LO</sub>	Input Clock Low Time	10% to 10%	0.5	_	ns
t <sub>STABLE</sub> <sup>5</sup>	STANDBY High to PLL Stable		_	15	ms
t <sub>RST</sub>	RST/RESETM Pulse Width		1	_	ns
t <sub>RSTREC</sub>	RST Recovery Time		1	_	ns
t <sub>RST_DIV</sub>	RESETC/D Pulse Width		10	_	ns
t <sub>RSTREC_DIV</sub>	RESETC/D Recovery Time		1	_	ns
t <sub>ROTATE-SETUP</sub>	PHASESTEP Setup Time		10	_	ns
t <sub>ROTATE_WD</sub>	PHASESTEP Pulse Width		4	_	VCO Cycles
	PHASESTEP Pulse Width  nple is taken over 10,000 samples of the primary PLL outp	ut with a clean reference clock. Cycle-t		s taken ove	-

Period jitter sample is taken over 10,000 samples of the primary PLL output with a clean reference clock. Cycle-to-cycle jitter is taken over 1000 cycles. Phase
jitter is taken over 2000 cycles. All values per JESD65B.

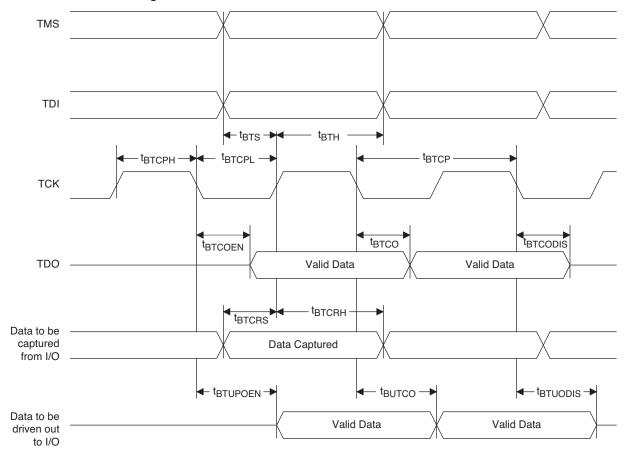
- 2. Output clock is valid after  $t_{LOCK}$  for PLL reset and dynamic delay adjustment.
- 3. Using LVDS output buffers.
- CLKOS as compared to CLKOP output for one phase step at the maximum VCO frequency. See TN1282, MachXO3 sysCLOCK PLL Design and Usage Guide for more details.
- 5. At minimum  $f_{\mbox{\scriptsize PFD}}$  As the  $f_{\mbox{\scriptsize PFD}}$  increases the time will decrease to approximately 60% the value listed.
- 6. Maximum allowed jitter on an input clock. PLL unlock may occur if the input jitter exceeds this specification. Jitter on the input clock may be transferred to the output clocks, resulting in jitter measurements outside the output specifications listed in this table.
- 7. Edge Duty Trim Accuracy is a percentage of the setting value. Settings available are 70 ps, 140 ps, and 280 ps in addition to the default value of none.
- 8. Jitter values measured with the internal oscillator operating. The jitter values will increase with loading of the PLD fabric and in the presence of SSO noise.



## **JTAG Port Timing Specifications**

Symbol	Parameter	Min.	Max.	Units
f <sub>MAX</sub>	TCK clock frequency	_	25	MHz
t <sub>BTCPH</sub>	TCK [BSCAN] clock pulse width high	20	_	ns
t <sub>BTCPL</sub>	TCK [BSCAN] clock pulse width low	20	_	ns
t <sub>BTS</sub>	TCK [BSCAN] setup time	10	_	ns
t <sub>BTH</sub>	TCK [BSCAN] hold time	8	_	ns
t <sub>BTCO</sub>	TAP controller falling edge of clock to valid output	_	10	ns
t <sub>BTCODIS</sub>	TAP controller falling edge of clock to valid disable	_	10	ns
t <sub>BTCOEN</sub>	TAP controller falling edge of clock to valid enable	_	10	ns
t <sub>BTCRS</sub>	BSCAN test capture register setup time	8	_	ns
t <sub>BTCRH</sub>	BSCAN test capture register hold time	20	_	ns
t <sub>BUTCO</sub>	BSCAN test update register, falling edge of clock to valid output	_	25	ns
t <sub>BTUODIS</sub>	BSCAN test update register, falling edge of clock to valid disable	_	25	ns
t <sub>BTUPOEN</sub>	BSCAN test update register, falling edge of clock to valid enable	_	25	ns

Figure 3-8. JTAG Port Timing Waveforms





	MachXO3L/LF-2100					
	WLCSP49	CSFBGA121	CSFBGA256	CSFBGA324	CABGA256	CABGA324
General Purpose IO per Bank			l.	l	l	I
Bank 0	19	24	50	71	50	71
Bank 1	0	26	52	62	52	68
Bank 2	13	26	52	72	52	72
Bank 3	0	7	16	22	16	24
Bank 4	0	7	16	14	16	16
Bank 5	6	10	20	27	20	28
Total General Purpose Single Ended IO	38	100	206	268	206	279
Differential IO per Bank	· ·		ı	l .	ı	l .
Bank 0	10	12	25	36	25	36
Bank 1	0	13	26	30	26	34
Bank 2	6	13	26	36	26	36
Bank 3	0	3	8	10	8	12
Bank 4	0	3	8	6	8	8
Bank 5	3	5	10	13	10	14
Total General Purpose Differential IO	19	49	103	131	103	140
Dual Function IO	25	33	33	37	33	37
Number 7:1 or 8:1 Gearboxes	•	•				
Number of 7:1 or 8:1 Output Gearbox Available (Bank 0)	5	7	14	18	14	18
Number of 7:1 or 8:1 Input Gearbox Available (Bank 2)	6	13	14	18	14	18
High-speed Differential Outputs	•	•				
Bank 0	5	7	14	18	14	18
VCCIO Pins	•	•				
Bank 0	2	1	4	4	4	4
Bank 1	0	1	3	4	4	4
Bank 2	1	1	4	4	4	4
Bank 3	0	1	2	2	1	2
Bank 4	0	1	2	2	2	2
Bank 5	1	1	2	2	1	2
vcc	2	4	8	8	8	10
GND	4	10	24	16	24	16
NC	0	0	0	13	1	0
Reserved for Configuration	1	1	1	1	1	1
Total Count of Bonded Pins	49	121	256	324	256	324



# MachXO3L Ultra Low Power Commercial and Industrial Grade Devices, Halogen Free (RoHS) Packaging

Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3L-640E-5MG121C	640	1.2 V	5	Halogen-Free csfBGA	121	COM
LCMXO3L-640E-6MG121C	640	1.2 V	6	Halogen-Free csfBGA	121	COM
LCMXO3L-640E-5MG121I	640	1.2 V	5	Halogen-Free csfBGA	121	IND
LCMXO3L-640E-6MG121I	640	1.2 V	6	Halogen-Free csfBGA	121	IND

Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3L-1300E-5UWG36CTR	1300	1.2 V	5	Halogen-Free WLCSP	36	COM
LCMXO3L-1300E-5UWG36CTR50	1300	1.2 V	5	Halogen-Free WLCSP	36	COM
LCMXO3L-1300E-5UWG36CTR1K	1300	1.2 V	5	Halogen-Free WLCSP	36	COM
LCMXO3L-1300E-5UWG36ITR	1300	1.2 V	5	Halogen-Free WLCSP	36	IND
LCMXO3L-1300E-5UWG36ITR50	1300	1.2 V	5	Halogen-Free WLCSP	36	IND
LCMXO3L-1300E-5UWG36ITR1K	1300	1.2 V	5	Halogen-Free WLCSP	36	IND
LCMXO3L-1300E-5MG121C	1300	1.2 V	5	Halogen-Free csfBGA	121	COM
LCMXO3L-1300E-6MG121C	1300	1.2 V	6	Halogen-Free csfBGA	121	COM
LCMXO3L-1300E-5MG121I	1300	1.2 V	5	Halogen-Free csfBGA	121	IND
LCMXO3L-1300E-6MG121I	1300	1.2 V	6	Halogen-Free csfBGA	121	IND
LCMXO3L-1300E-5MG256C	1300	1.2 V	5	Halogen-Free csfBGA	256	COM
LCMXO3L-1300E-6MG256C	1300	1.2 V	6	Halogen-Free csfBGA	256	COM
LCMXO3L-1300E-5MG256I	1300	1.2 V	5	Halogen-Free csfBGA	256	IND
LCMXO3L-1300E-6MG256I	1300	1.2 V	6	Halogen-Free csfBGA	256	IND
LCMXO3L-1300C-5BG256C	1300	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	COM
LCMXO3L-1300C-6BG256C	1300	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	COM
LCMXO3L-1300C-5BG256I	1300	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	IND
LCMXO3L-1300C-6BG256I	1300	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	IND

Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3L-2100E-5UWG49CTR	2100	1.2 V	5	Halogen-Free WLCSP	49	COM
LCMXO3L-2100E-5UWG49CTR50	2100	1.2 V	5	Halogen-Free WLCSP	49	COM
LCMXO3L-2100E-5UWG49CTR1K	2100	1.2 V	5	Halogen-Free WLCSP	49	COM
LCMXO3L-2100E-5UWG49ITR	2100	1.2 V	5	Halogen-Free WLCSP	49	IND
LCMXO3L-2100E-5UWG49ITR50	2100	1.2 V	5	Halogen-Free WLCSP	49	IND
LCMXO3L-2100E-5UWG49ITR1K	2100	1.2 V	5	Halogen-Free WLCSP	49	IND
LCMXO3L-2100E-5MG121C	2100	1.2 V	5	Halogen-Free csfBGA	121	COM
LCMXO3L-2100E-6MG121C	2100	1.2 V	6	Halogen-Free csfBGA	121	COM
LCMXO3L-2100E-5MG121I	2100	1.2 V	5	Halogen-Free csfBGA	121	IND
LCMXO3L-2100E-6MG121I	2100	1.2 V	6	Halogen-Free csfBGA	121	IND
LCMXO3L-2100E-5MG256C	2100	1.2 V	5	Halogen-Free csfBGA	256	COM
LCMXO3L-2100E-6MG256C	2100	1.2 V	6	Halogen-Free csfBGA	256	COM
LCMXO3L-2100E-5MG256I	2100	1.2 V	5	Halogen-Free csfBGA	256	IND
LCMXO3L-2100E-6MG256I	2100	1.2 V	6	Halogen-Free csfBGA	256	IND
LCMXO3L-2100E-5MG324C	2100	1.2 V	5	Halogen-Free csfBGA	324	COM
LCMXO3L-2100E-6MG324C	2100	1.2 V	6	Halogen-Free csfBGA	324	COM
LCMXO3L-2100E-5MG324I	2100	1.2 V	5	Halogen-Free csfBGA	324	IND



Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3LF-2100E-6MG324I	2100	1.2 V	6	Halogen-Free csfBGA	324	IND
LCMXO3LF-2100C-5BG256C	2100	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	COM
LCMXO3LF-2100C-6BG256C	2100	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	COM
LCMXO3LF-2100C-5BG256I	2100	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	IND
LCMXO3LF-2100C-6BG256I	2100	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	IND
LCMXO3LF-2100C-5BG324C	2100	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	COM
LCMXO3LF-2100C-6BG324C	2100	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	COM
LCMXO3LF-2100C-5BG324I	2100	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	IND
LCMXO3LF-2100C-6BG324I	2100	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	IND

Part Number	LUTs	Supply Voltage	Speed	Package	Leads	Temp.
LCMXO3LF-4300E-5UWG81CTR	4300	1.2 V	5	Halogen-Free WLCSP	81	COM
LCMXO3LF-4300E-5UWG81CTR50	4300	1.2 V	5	Halogen-Free WLCSP	81	COM
LCMXO3LF-4300E-5UWG81CTR1K	4300	1.2 V	5	Halogen-Free WLCSP	81	COM
LCMXO3LF-4300E-5UWG81ITR	4300	1.2 V	5	Halogen-Free WLCSP	81	IND
LCMXO3LF-4300E-5UWG81ITR50	4300	1.2 V	5	Halogen-Free WLCSP	81	IND
LCMXO3LF-4300E-5UWG81ITR1K	4300	1.2 V	5	Halogen-Free WLCSP	81	IND
LCMXO3LF-4300E-5MG121C	4300	1.2 V	5	Halogen-Free csfBGA	121	COM
LCMXO3LF-4300E-6MG121C	4300	1.2 V	6	Halogen-Free csfBGA	121	COM
LCMXO3LF-4300E-5MG121I	4300	1.2 V	5	Halogen-Free csfBGA	121	IND
LCMXO3LF-4300E-6MG121I	4300	1.2 V	6	Halogen-Free csfBGA	121	IND
LCMXO3LF-4300E-5MG256C	4300	1.2 V	5	Halogen-Free csfBGA	256	COM
LCMXO3LF-4300E-6MG256C	4300	1.2 V	6	Halogen-Free csfBGA	256	COM
LCMXO3LF-4300E-5MG256I	4300	1.2 V	5	Halogen-Free csfBGA	256	IND
LCMXO3LF-4300E-6MG256I	4300	1.2 V	6	Halogen-Free csfBGA	256	IND
LCMXO3LF-4300E-5MG324C	4300	1.2 V	5	Halogen-Free csfBGA	324	COM
LCMXO3LF-4300E-6MG324C	4300	1.2 V	6	Halogen-Free csfBGA	324	COM
LCMXO3LF-4300E-5MG324I	4300	1.2 V	5	Halogen-Free csfBGA	324	IND
LCMXO3LF-4300E-6MG324I	4300	1.2 V	6	Halogen-Free csfBGA	324	IND
LCMXO3LF-4300C-5BG256C	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	COM
LCMXO3LF-4300C-6BG256C	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	COM
LCMXO3LF-4300C-5BG256I	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	256	IND
LCMXO3LF-4300C-6BG256I	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	256	IND
LCMXO3LF-4300C-5BG324C	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	COM
LCMXO3LF-4300C-6BG324C	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	324	COM
LCMXO3LF-4300C-5BG324I	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	324	IND
LCMXO3LF-4300C-6BG324I 4300		2.5 V / 3.3 V	6	Halogen-Free caBGA	324	IND
LCMXO3LF-4300C-5BG400C	.CMXO3LF-4300C-5BG400C 4300 2.5 V / 3.3		5	Halogen-Free caBGA	400	COM
LCMXO3LF-4300C-6BG400C	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	400	COM
LCMXO3LF-4300C-5BG400I	4300	2.5 V / 3.3 V	5	Halogen-Free caBGA	400	IND
LCMXO3LF-4300C-6BG400I	4300	2.5 V / 3.3 V	6	Halogen-Free caBGA	400	IND



# MachXO3 Family Data Sheet Supplemental Information

January 2016 Advance Data Sheet DS1047

## For Further Information

A variety of technical notes for the MachXO3 family are available on the Lattice web site.

- TN1282, MachXO3 sysCLOCK PLL Design and Usage Guide
- TN1281, Implementing High-Speed Interfaces with MachXO3 Devices
- TN1280, MachXO3 sysIO Usage Guide
- TN1279, MachXO3 Programming and Configuration Usage Guide
- TN1074, PCB Layout Recommendations for BGA Packages
- TN1087, Minimizing System Interruption During Configuration Using TransFR Technology
- AN8066, Boundary Scan Testability with Lattice sysIO Capability
- MachXO3 Device Pinout Files
- Thermal Management document
- · Lattice design tools



# MachXO3 Family Data Sheet Revision History

February 2017 Advance Data Sheet DS1047

Date	Version	Section	Change Summary
February 2017			Updated Supported Standards section. Corrected "MDVS" to "MLDVS" in Table 2-11, Supported Input Standards.
		DC and Switching Characteristics	Updated ESD Performance section. Added reference to the MachXO2 Product Family Qualification Summary document.
			Updated Static Supply Current – C/E Devices section. Added footnote 7.
			Updated MachXO3L/LF External Switching Characteristics – C/E Devices section.  — Populated values for MachXO3L/LF-9400.  — Under 7:1 LVDS Outputs – GDDR71_TX.ECLK.7:1, corrected "t <sub>DVB</sub> " to "t <sub>DIB</sub> " and "t <sub>DVA</sub> " to "t <sub>DIA</sub> " and revised their descriptions.  — Added Figure 3-6, Receiver GDDR71_RX Waveforms and Figure 3-7, Transmitter GDDR71_TX Waveforms.
		Pinout Information	Updated the Pin Information Summary section. Added MachXO3L/LF-9600C packages.
May 2016	1.7	DC and Switching Characteristics	Updated Absolute Maximum Ratings section. Modified I/O Tri-state Voltage Applied and Dedicated Input Voltage Applied footnotes.
			Updated sysIO Recommended Operating Conditions section.  — Added standards.  — Added V <sub>REF</sub> (V)  — Added footnote 4.
			Updated sysIO Single-Ended DC Electrical Characteristics section. Added I/O standards.
	Ordering Information	Updated MachXO3L Ultra Low Power Commercial and Industrial Grade Devices, Halogen Free (RoHS) Packaging section. Added LCMXO3L-9400C part numbers.	
			Updated MachXO3LF Ultra Low Power Commercial and Industrial Grade Devices, Halogen Free (RoHS) Packaging section. Added LCMXO3L-9400C part numbers.